

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	Examiner	Art Unit	
	Rip A. Lee	1713	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	K	US-			
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*	N	EP 612 768 A1	02-1994	Japan	Hasegawa et al.	C08F 210/16
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NON-PATENT DOCUMENTS

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